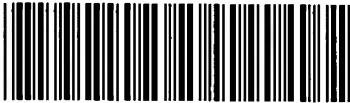
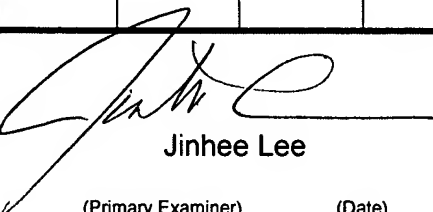



Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/533,556	PARK, JOON-YOUNG	
	Examiner	Art Unit	
	Jinhee J. Lee	2831	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
174	5r			174	5sg	6				
INTERNATIONAL CLASSIFICATION										
H	0	1	b	13/00						
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				/						
				 Jinhee Lee (Primary Examiner) (Date)				Total Claims Allowed: 2 O.G. Print Claim(s) O.G. Print Fig. 1 1, 4		
 (Assistant Examiner) (Date) (Legal Instruments Examiner) (Date)										

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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